

Notice of References Cited	Application/Control No. 10/665,028	Applicant(s)/Patent Under Reexamination HU, YIPING	
	Examiner Samuel M. Heinrich	Art Unit 1725	Page 1 of 1

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*	B	US-H389	12-1987	Moon	372/58
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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